

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
		Examiner Christopher RoDee	Art Unit 1756	Page 1 of 1

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*	C	US-5,753,399	05-1998	Hayase et al.	430/111.4
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	L	US-			
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NON-PATENT DOCUMENTS

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*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
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